



Power MOSFET

PRODUCT SUMMARY		
V_{DS} (V)	60	
$R_{DS(on)}$ (Ω)	$V_{GS} = 10$ V	0.018
Q_g (Max.) (nC)	110	
Q_{gs} (nC)	29	
Q_{gd} (nC)	36	
Configuration	Single	

FEATURES

- Advanced process technology
- Surface mount (IRFZ48S, SiHFZ48S)
- Low-profile through-hole (IRFZ48L, SiHFZ48L)
- 175 °C operating temperature
- Fast switching
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

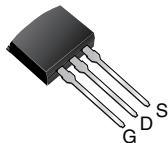


RoHS*
Available
HALOGEN FREE
Available

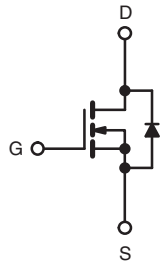
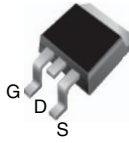
Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non-RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details.

I²PAK (TO-262)



D²PAK (TO-263)



N-Channel MOSFET

DESCRIPTION

Third generation power MOSFETs from Vishay utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D²PAK is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D²PAK is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2 W in a typical surface mount application.

The through-hole version (IRFZ48L, SiHFZ48L) is available for low-profile applications.

ORDERING INFORMATION		
Package	D ² PAK (TO-263)	I ² PAK (TO-262)
Lead (Pb)-free and halogen-free	SiHFZ48S-GE3	SiHFZ48L-GE3
Lead (Pb)-free	IRFZ48SPbF	-

Note

- a. See device orientation.

ABSOLUTE MAXIMUM RATINGS ($T_C = 25$ °C, unless otherwise noted)				
PARAMETER	SYMBOL		LIMIT	UNIT
Drain-Source Voltage	V_{DS}		60	V
Gate-Source Voltage	V_{GS}		± 20	
Continuous Drain Current ^f	V_{GS} at 10 V	$T_C = 25$ °C	50	A
		$T_C = 100$ °C	50	
Pulsed Drain Current ^{a, e}	I_{DM}		290	
Linear Derating Factor			1.3	W/°C
Single Pulse Avalanche Energy ^{b, e}	E_{AS}		100	mJ
Maximum Power Dissipation	$T_C = 25$ °C		190	W
	$T_A = 25$ °C		3.7	
Peak Diode Recovery dV/dt ^{c, e}	dV/dt		4.5	V/ns
Operating Junction and Storage Temperature Range	T_J, T_{stg}		-55 to +175	°C
Soldering Recommendations (Peak temperature) ^d	for 10 s		300	

Notes


- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = 25$ V, Starting $T_J = 25$ °C, $L = 22$ μ H, $R_g = 25$ Ω , $I_{AS} = 72$ A (see fig. 12).
- $I_{SP} \leq 72$ A, $dI/dt \leq 200$ A/ μ s, $V_{DD} \leq V_{DS}$, $T_J \leq 175$ °C.
- 1.6 mm from case.
- Uses IRFZ48, SiHFZ48 data and test conditions.
- Calculated continuous current based on maximum allowable junction temperature.



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient (PCB mount) ^a	R _{thJA}	-	40	°C / W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.8	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0, I _D = 250 μA	60	-	-	V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	Reference to 25 °C, I _D = 1 mA ^c	-	0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V	-	-	25	μA
		V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C	-	-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 43 A ^b	-	-	0.018	Ω
Forward Transconductance	g _{fs}	V _{DS} = 25 V, I _D = 43 A ^b	27	-	-	S
Dynamic						
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5 ^c	-	2400	-	pF
Output Capacitance	C _{oss}		-	1300	-	
Reverse Transfer Capacitance	C _{rss}		-	190	-	
Total Gate Charge	Q _g	V _{GS} = 10 V, I _D = 72 A, V _{DS} = 48 V, see fig. 6 and 13 ^{b, c}	-	-	110	nC
Gate-Source Charge	Q _{gs}		-	-	29	
Gate-Drain Charge	Q _{gd}		-	-	36	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 30 V, I _D = 72 A, R _g = 9.1 Ω, R _D = 0.34 Ω, see fig. 10 ^{b, c}	-	8.1	-	ns
Rise Time	t _r		-	250	-	
Turn-Off Delay Time	t _{d(off)}		-	210	-	
Fall Time	t _f		-	250	-	
Internal Source Inductance	L _S	Between lead, and center of die contact	-	7.5	-	nH
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode 	-	-	50 ^c	A
Pulsed Diode Forward Current ^a	I _{SM}		-	-	290	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 72 A, V _{GS} = 0 V ^b	-	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 72 A, dI/dt = 100 A/μs ^{b, c}	-	120	180	ns
Body Diode Reverse Recovery Charge	Q _{rr}		-	500	800	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.
- c. Uses IRFZ48/SiHFZ48 data and test conditions.
- d. Calculated continuous current based on maximum allowable junction temperature.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

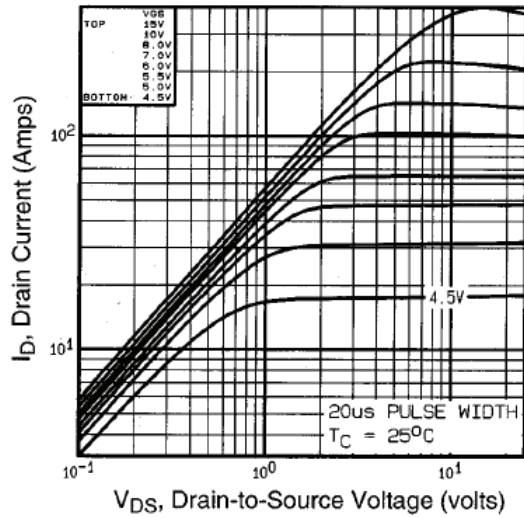


Fig. 1 - Typical Output Characteristics

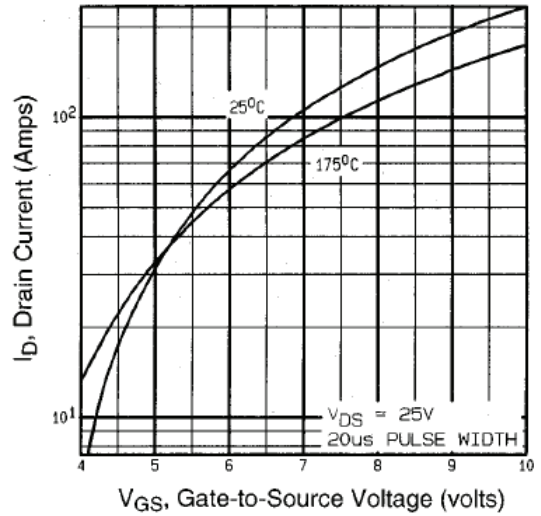


Fig. 3 - Typical Transfer Characteristics

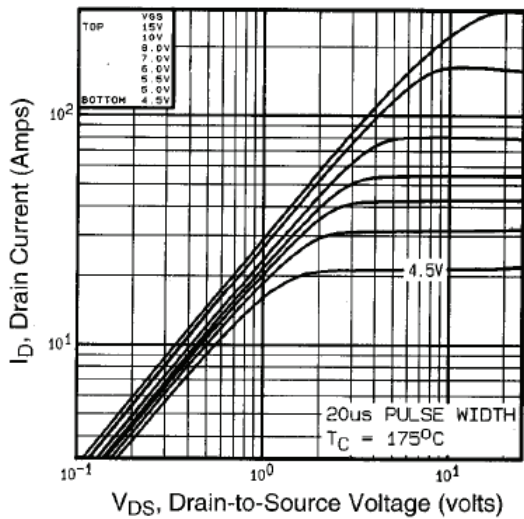


Fig. 2 - Typical Output Characteristics

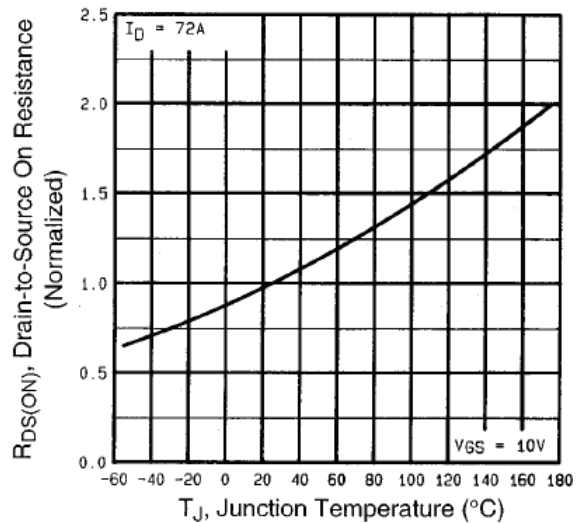


Fig. 4 - Normalized On-Resistance vs. Temperature

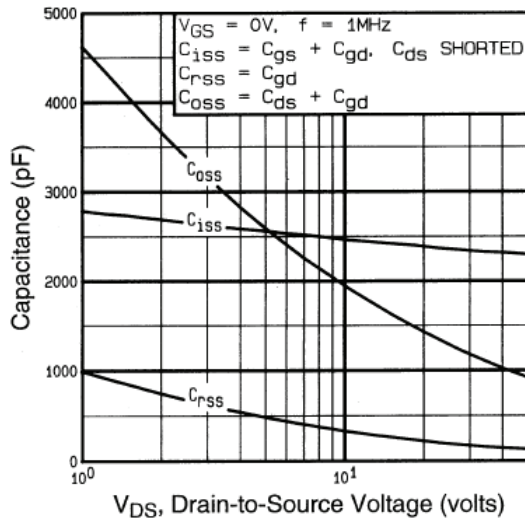


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

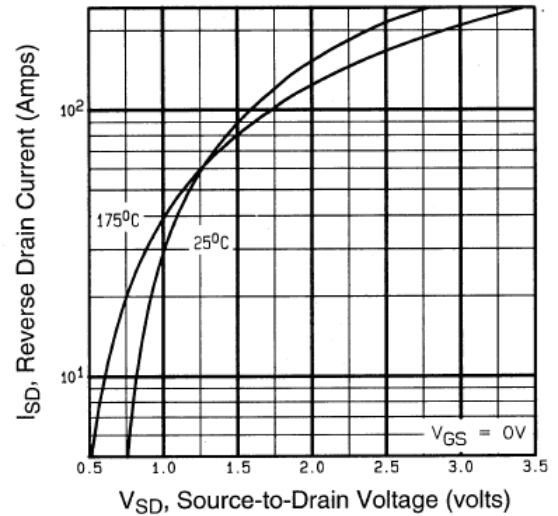


Fig. 7 - Typical Source-Drain Diode Forward Voltage

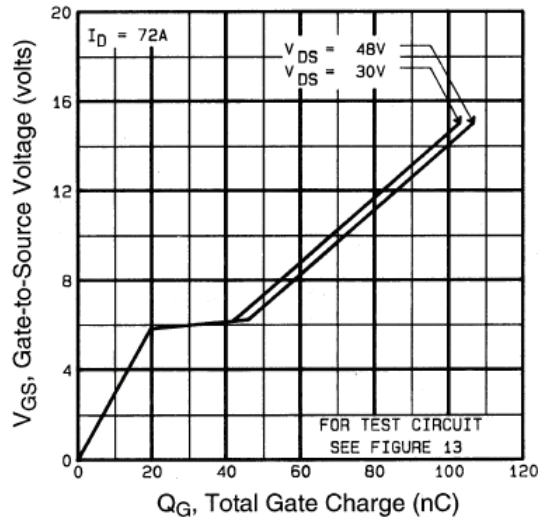


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

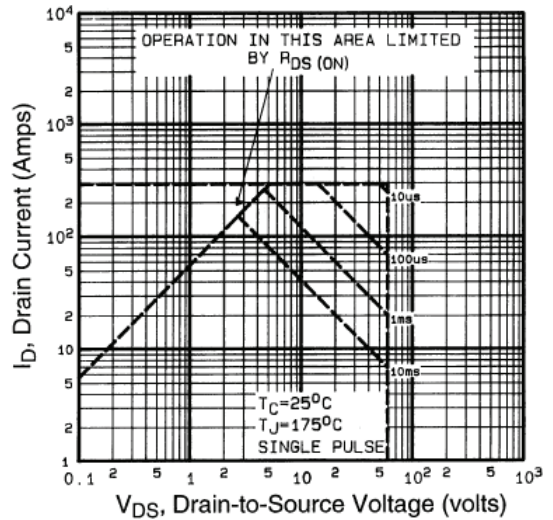


Fig. 8 - Maximum Safe Operating Area

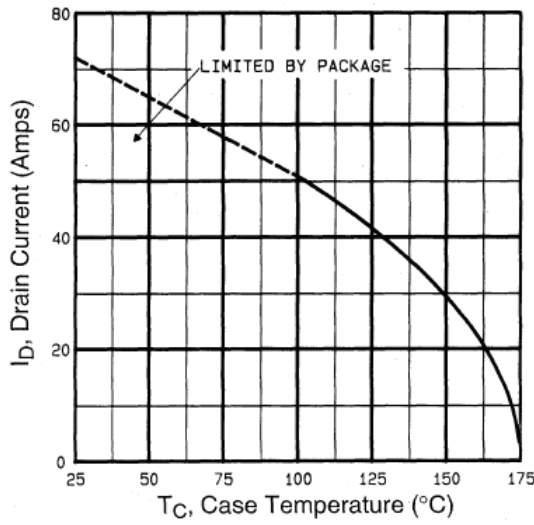


Fig. 9 - Maximum Drain Current vs. Case Temperature

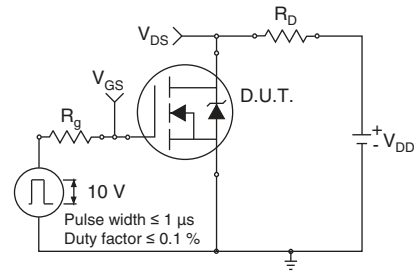


Fig. 10a - Switching Time Test Circuit

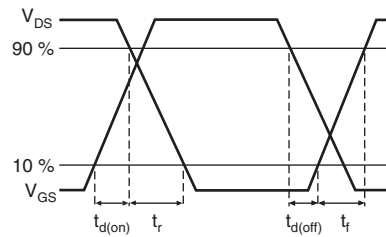


Fig. 10b - Switching Time Waveform

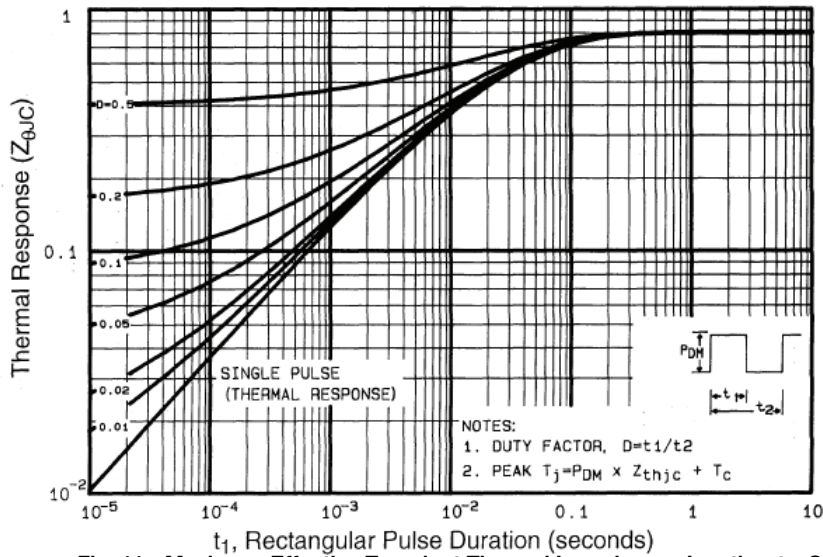


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

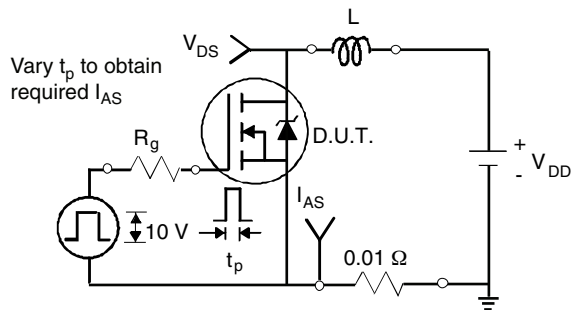


Fig. 12a - Unclamped Inductive Test Circuit

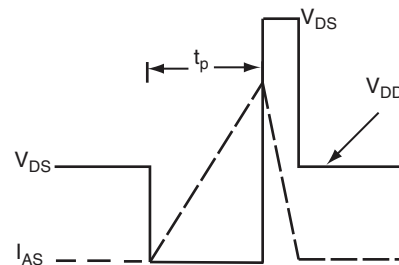


Fig. 12b - Unclamped Inductive Waveforms

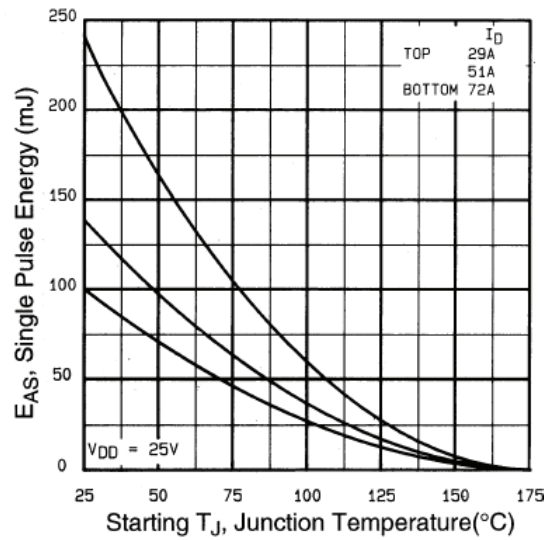


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

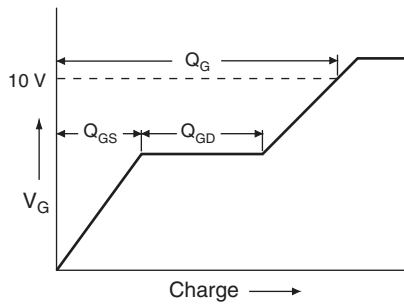


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

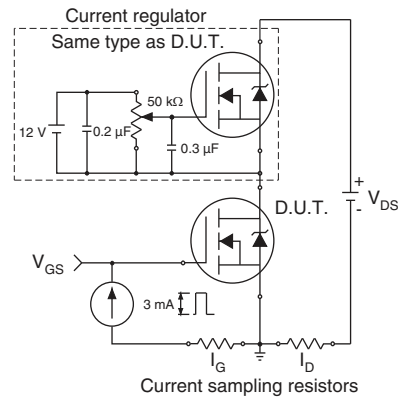
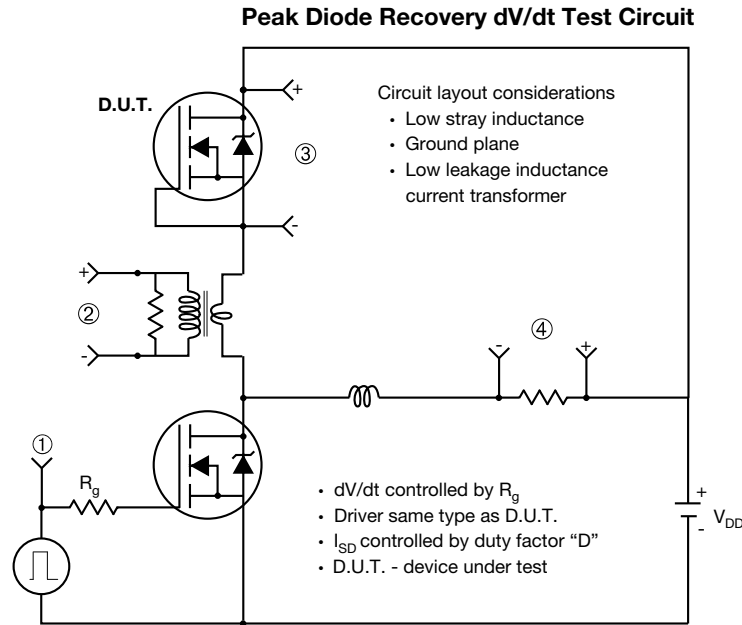


Fig. 13b - Gate Charge Test Circuit



Note

a. $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?90377.

TO-263AB (HIGH VOLTAGE)



DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
c	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
e	2.54 BSC		0.100 BSC	
H	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	-	0.066
L2	-	1.78	-	0.070
L3	0.25 BSC		0.010 BSC	
L4	4.78	5.28	0.188	0.208

ECN: S-82110-Rev. A, 15-Sep-08
DWG: 5970

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.
2. Dimensions are shown in millimeters (inches).
3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
5. Dimension b1 and c1 apply to base metal only.
6. Datum A and B to be determined at datum plane H.
7. Outline conforms to JEDEC outline to TO-263AB.



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